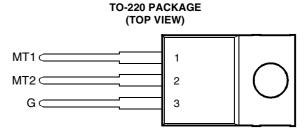
# Bourns®

- 8 A RMS
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I<sub>GT</sub> of 50 mA (Quadrants 1 3)



Pin 2 is in electrical contact with the mounting base.

### absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING			VALUE	UNIT
	TIC226D		400	
Repetitive peak off-state voltage (see Note 1)	TIC226M		600	v
	TIC226S	VDRM	700	v
	TIC226N		800	
Full-cycle RMS on-state current at (or below) 85°C case temperature (see Note	I <sub>T(RMS)</sub>	8	А	
Peak on-state surge current full-sine-wave at (or below) 25°C case temperature (see Note 3)			70	А
Peak gate current	I <sub>GM</sub>	±1	А	
Peak gate power dissipation at (or below) 85°C case temperature (pulse width s	P <sub>GM</sub>	2.2	W	
Average gate power dissipation at (or below) 85°C case temperature (see Note 4)			0.9	W
Operating case temperature range			-40 to +110	°C
Storage temperature range			-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds			230	°C

NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.

2. This value applies for 50-Hz full-sine-wave operation with resistive load. Above 85°C derate linearly to 110°C case temperature at the rate of 320 mA/°C.

- This value applies for one 50-Hz full-sine-wave when the device is operating at (or below) the rated value of on-state current. Surge
  may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.
- 4. This value applies for a maximum averaging time of 20 ms.

### electrical characteristics at 25°C case temperature (unless otherwise noted )

	PARAMETER	TEST CONDITIONS			MIN	ТҮР	MAX	UNIT
I <sub>DRM</sub>	Repetitive peak off-state current	$V_D = rated V_{DRM}$	$I_{G} = 0$	$T_{\rm C} = 110^{\circ}{\rm C}$			±2	mA
I <sub>GT</sub>		V <sub>supply</sub> = +12 V†	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		6	50	mA
	Gate trigger	V <sub>supply</sub> = +12 V†	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-12	-50	
	current	V <sub>supply</sub> = -12 V†	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-10	-50	
		$V_{supply} = -12 V^{+}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		25		
V <sub>GT</sub>		V <sub>supply</sub> = +12 V†	R <sub>L</sub> = 10 Ω	t <sub>p(g)</sub> > 20 μs		0.7	2	V
	Gate trigger	V <sub>supply</sub> = +12 V†	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-0.8	-2	
	voltage	V <sub>supply</sub> = -12 V†	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-0.8	-2	
		$V_{supply} = -12 V^{+}$	$R_L = 10 \ \Omega$	t <sub>p(g)</sub> > 20 μs		0.9	2	
V <sub>T</sub>	On-state voltage	$I_T = \pm 12 \text{ A}$	l <sub>G</sub> = 50 mA	(see Note 5)		±1.5	±2.1	V

† All voltages are with respect to Main Terminal 1.

# PRODUCT INFORMATION

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# electrical characteristics at 25°C case temperature (unless otherwise noted) (continued)

PARAMETER TEST CONDITIONS		MIN	ТҮР	MAX	UNIT			
I <sub>Н</sub>	Holding current	$V_{supply} = +12 V^{+}$ $V_{supply} = -12 V^{+}$	l <sub>G</sub> = 0 l <sub>G</sub> = 0	Init' I <sub>TM</sub> = 100 mA Init' I <sub>TM</sub> = -100 mA		10 -6	30 -30	mA
IL.	Latching current	V <sub>supply</sub> = +12 V† V <sub>supply</sub> = -12 V†	(see Note 6)				50 -50	mA
dv/dt	Critical rate of rise of off-state voltage	$V_{DRM}$ = Rated $V_{DRM}$	l <sub>G</sub> = 0	T <sub>C</sub> = 110°C		±100		V/µs
dv/dt <sub>(c)</sub>	Critical rise of commu- tation voltage	$V_{DRM}$ = Rated $V_{DRM}$	$I_{TRM} = \pm 12 \text{ A}$	T <sub>C</sub> = 85°C (see figure 7)	±5			V/µs

† All voltages are with respect to Main Terminal 1.

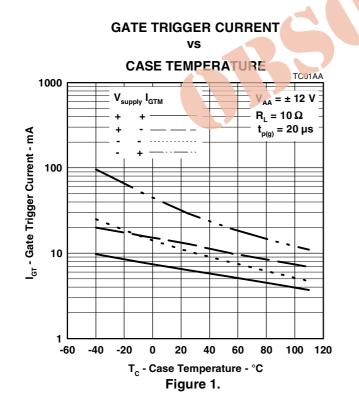
NOTES: 5. This parameter must be measured using pulse techniques,  $t_p = \le 1$  ms, duty cycle  $\le 2$  %. Voltage-sensing contacts separate from the current carrying contacts are located within 3.2 mm from the device body.

6. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics:  $R_G = 100 \ \Omega$ ,  $t_{p(g)} = 20 \ \mu$ s,  $t_r = \le 15 \ n$ s,  $f = 1 \ kHz$ .

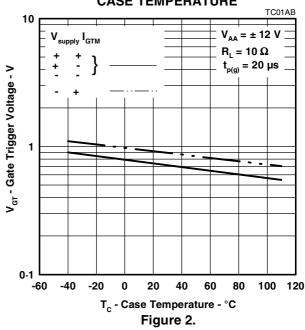
## thermal characteristics

PARAMETER			TYP	MAX	UNIT
$R_{\thetaJC}$	Junction to case thermal resistance			1.8	°C/W
R <sub>0JA</sub>	Junction to free air thermal resistance			62.5	°C/W

TYPICAL CHARACTERISTICS



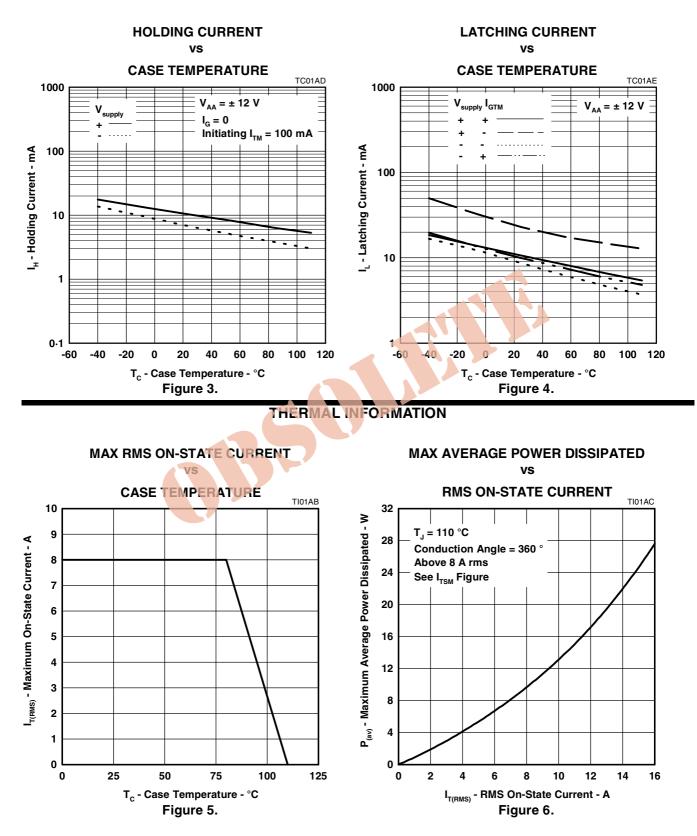
GATE TRIGGER VOLTAGE vs



**CASE TEMPERATURE** 

PRODUCT INFORMATION

# **TYPICAL CHARACTERISTICS**



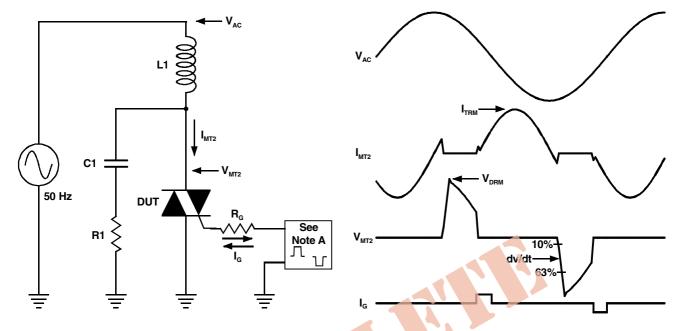
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## PARAMETER MEASUREMENT INFORMATION



NOTE A: The gate-current pulse is furnished by a trigger circuit which presents essentially an open circuit between pulses. The pulse is timed so that the off-state-voltage duration is approximately 800 µs.

PMC2AA

Figure 7.

